REI Datasheet

## 54ACT11280, 74ACT11280

## 9-Bit Parity Generators/Checkers

These universal, monolithic, 9-bit parity generators/checkers feature odd and even outputs to facilitate operation of either an odd or even parity application. The word-length capability is easily expanded by cascading.

The 54ACT11280 is characterized for operation over the full military temperature range of $-55^{\circ} \mathrm{C}$ to $125^{\circ} \mathrm{C}$ while the 74 ACT 11280 is characterized for operation from $-40^{\circ} \mathrm{C}$ to $85^{\circ} \mathrm{C}$.

## Rochester Electronics Manufactured Components

Rochester branded components are manufactured using either die/wafers purchased from the original suppliers or Rochester wafers recreated from the original IP. All recreations are done with the approval of the OCM.

Parts are tested using original factory test programs or Rochester developed test solutions to guarantee product meets or exceeds the OCM data sheet.

## Quality Overview

- ISO-9001
- AS9120 certification
- Qualified Manufacturers List (QML) MIL-PRF-38535
- Class Q Military
- Class V Space Level
- Qualified Suppliers List of Distributors (QSLD)
- Rochester is a critical supplier to DLA and meets all industry and DLA standards.

Rochester Electronics, LLC is committed to supplying products that satisfy customer expectations for quality and are equal to those originally supplied by industry manufacturers.

The original manufacturer's datasheet accompanying this document reflects the performance and specifications of the Rochester manufactured version of this device. Rochester Electronics guarantees the performance of its semiconductor products to the original OEM specifications. 'Typical' values are for reference purposes only. Certain minimum or maximum ratings may be based on product characterization, design, simulation, or sample testing.

- Inputs Are TTL-Voltage Compatible
- Generates Either Odd or Even Parity for Nine Data Lines
- Cascadable for n-Bits Parity
- Flow-Through Architecture Optimizes PCB Layout
- Center-Pin $\mathrm{V}_{\mathrm{CC}}$ and GND Configurations Minimize High-Speed Switching Noise
- EPIC ${ }^{\text {ma }}$ (Enhanced-Performance Implanted CMOS) $1-\mu \mathrm{m}$ Process
- 500-mA Typical Latch-Up Immunity at $125^{\circ} \mathrm{C}$
- Package Options Include Plastic Small-Outline Packages, Ceramic Chip Carriers, and Standard Plastic and Ceramic 300-mil DIPs


## description

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FUNCTION TABLE

| NUMBER OF INPUTS <br> A THRU I <br> THAT ARE HIGH | OUTPUTS |  |
| :---: | :---: | :---: |
|  | $\Sigma$ EVEN | $\Sigma$ ODD |
| $0,2,4,6,8$ | H | L |
| $1,3,5,7,9$ | L | H |


(TOP VIEW)


NC - No internal connection
logic symbol $\dagger$

$\dagger$ This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.
Pin numbers shown are for the $\mathrm{D}, \mathrm{J}$, and N packages.
logic diagram (positive logic)


Pin numbers shown are for the $\mathrm{D}, \mathrm{J}$, and N packages.
absolute maximum ratings over operating free-air temperature range (unless otherwise noted) $\dagger$Supply voltage range, $\mathrm{V}_{\mathrm{C}}$-0.5 V to 7 V
Input voltage range, $\mathrm{V}_{1}$ (see Note 1) ..... -0.5 V to $\mathrm{V}_{\mathrm{CC}}+0.5 \mathrm{~V}$
Output voltage range, $\mathrm{V}_{\mathrm{O}}$ (see Note 1) ..... -0.5 V to $\mathrm{V}_{\mathrm{CC}}+0.5 \mathrm{~V}$
Input clamp current, $\mathrm{I}_{\mathrm{IK}}\left(\mathrm{V}_{1}<0\right.$ or $\left.\mathrm{V}_{1}>\mathrm{V}_{\mathrm{CC}}\right)$ ..... $\pm 20 \mathrm{~mA}$
Output clamp current, $\mathrm{I}_{\mathrm{OK}}\left(\mathrm{V}_{\mathrm{O}}<0\right.$ or $\left.\mathrm{V}_{\mathrm{O}}>\mathrm{V}_{\mathrm{CC}}\right)$ ..... $\pm 50 \mathrm{~mA}$
Continuous output current, $\mathrm{I}_{\mathrm{O}}\left(\mathrm{V}_{\mathrm{O}}=0\right.$ to $\left.\mathrm{V}_{\mathrm{CC}}\right)$ ..... $\pm 50 \mathrm{~mA}$
Continuous current through $\mathrm{V}_{\mathrm{CC}}$ or GND ..... $\pm 00 \mathrm{~mA}$
Storage temperature range$-65^{\circ} \mathrm{C}$ to $150^{\circ} \mathrm{C}$

[^0]SCAS046A－D3148，AUGUST 1988 －REVISED APRIL 1993
recommended operating conditions

|  |  | 54ACT11280 |  | 74ACT11280 |  | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | MIN | MAX | MIN | MAX |  |
| $\mathrm{V}_{\text {CC }}$ | Supply voltage | 4.5 | 5.5 | 4.5 | 5.5 | V |
| $\mathrm{V}_{\mathrm{IH}}$ | High－level input voltage | 2 |  | 2 |  | V |
| $\mathrm{V}_{\mathrm{IL}}$ | Low－level input voltage |  | 0.8 |  | 0.8 | V |
| $V_{1}$ | Input voltage | 0 | $\mathrm{V}_{\mathrm{CC}}$ | 0 | $\mathrm{V}_{\mathrm{CC}}$ | V |
| $\mathrm{V}_{\mathrm{O}}$ | Output voltage | 0 | $\mathrm{V}_{\text {CC }}$ | 0 | $\mathrm{V}_{\text {CC }}$ | V |
| $\mathrm{IOH}^{2}$ | High－level output current |  | －24 |  | －24 | mA |
| IOL | Low－level output current |  | 24 |  | 24 | mA |
| $\Delta t / \Delta v$ | Input transition rise or fall rate | 0 | 10 | 0 | 10 | $\mathrm{ns} / \mathrm{V}$ |
| $\mathrm{T}_{\text {A }}$ | Operating free－air temperature | －55 | 125 | －40 | 85 | ${ }^{\circ} \mathrm{C}$ |

electrical characteristics over recommended operating free－air temperature range（unless otherwise noted）

$\dagger$ Not more than one output should be tested at a time and the duration of the test should not exceed 10 ms ．
$\ddagger$ This is the increase in supply current for each input that is at one of the specified TTL voltage levels rather than 0 V or $\mathrm{V}_{\mathrm{CC}}$ ．
switching characteristics over recommended ranges of supply voltage and operating free－air temperature（unless otherwise noted）（see Figure 1）

| PARAMETER | FROM （INPUT） | TO （OUTPUT） | $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$ |  |  | 54ACT11280 |  | 74ACT11280 |  | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  | MIN | TYP | MAX | MIN | MAX | MIN | MAX |  |
| tpLH | Any input | $\Sigma$ EVEN | 1.5 | 7.3 | 10.8 | 1.5 | 13.1 | 1.5 | 12.2 | ns |
| tPHL |  |  | 1.5 | 8.8 | 12.5 | 1.5 | 15.6 | 1.5 | 14.3 |  |
| tpLH | Any input | $\Sigma$ ODD | 1.5 | 7.3 | 10.8 | 1.5 | 12.9 | 1.5 | 12.1 | ns |
| ${ }^{\text {tPHL }}$ |  |  | 1.5 | 8.6 | 12.4 | 1.5 | 15.7 | 1.5 | 14.3 |  |

## 9-BIT PARITY GENERATORS/CHECKERS

SCAS046A - D3148, AUGUST 1988-REVISED APRIL 1993
operating characteristics, $\mathrm{V}_{\mathrm{CC}}=5 \mathrm{~V}, \mathrm{~T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$

| PARAMETER | TEST CONDITIONS | TYP | UNIT |
| :--- | :---: | :---: | :---: |
| $\mathrm{C}_{\text {pd }}$ | Power dissipation capacitance | $\mathrm{C}_{\mathrm{L}}=50 \mathrm{pF}, \quad \mathrm{f}=1 \mathrm{MHz}$ | 56 |

PARAMETER MEASUREMENT INFORMATION


NOTES: A. $C_{L}$ includes probe and jig capacitance.
B. Input pulses are supplied by generators having the following characteristics: PRR $\leq 10 \mathrm{MHz}, \mathrm{Z}_{\mathrm{O}}=50 \Omega, \mathrm{t}_{\mathrm{r}}=3 \mathrm{~ns}, \mathrm{t}_{\mathrm{f}}=3 \mathrm{~ns}$.
C. The outputs are measured one at a time with one input transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms


[^0]:    $\dagger$ Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
    NOTE 1: The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

